

Notice of References Cited

Application/Control No.

10/623,603

Applicant(s)/Patent Under
Reexamination
GUAN ET AL.

Examiner

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Art Unit

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,647,010 A	07-1997	Okubo et al.	382/100
*	B	US-2005/0190411 A1	09-2005	Ohno, Hajime	358/3.28
*	C	US-2007/0041608 A1	02-2007	Maeno, Kurato	382/100
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 02029679 A	01-1990	Japan	MAEKAWA, HIROICHI	B41M 3/14
	O	JP 2001346032 A	12-2001	Japan	MATSUNOSHITA et al.	H04N 1/387
	P	JP 2001069340 A	03-2001	Japan	SAKAGAMI, TSUTOMU	H04N 1/387
	Q	JP 2002305646 A	10-2002	Japan	MATSUNOSHITA et al.	H04N 1/382
	R	JP 2002112356 A	04-2002	Japan	YAMAKADO et al.	H04N 1/387
	S	JP 2002112357 A	04-2002	Japan	YAMAGUCHI et al.	H04N 1/387
	T	JP 09164739 A	06-1997	Japan	KONNAI, KATSUMI	G06F 3/12

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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